

Search Notes

Application/Control No.

10/729,655

Examiner

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Applicant(s)/Patent under
Reexamination

SHIEH, SHIUH-AN

Art Unit

2632

SEARCHED

Class	Subclass	Date	Examiner
340	561	2/28/2006	TN
340	66	2/28/2006	TN
340	667	2/28/2006	TN
340	668	2/28/2006	TN
701	45	2/29/2006	TN
701	46	2/29/2006	TN
701	47	2/29/2006	TN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST SEARCH	2/28/2006	TN
CONSULT WITH BEN LEE	2/29/2006	TN